

**Search Notes**

Application/Control No.

10/028,029

Examiner

Gopal C. Ray

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	22,300,30 8,72,74,24 0,241,113	5/17/2005	GCR
711	100,202	5/17/2005	GCR
709	208,212	5/18/2005	GCR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB	5/17/2005	GCR
EAST: USPT	5/17/2005	GCR
NPL: IEEE Xplore	5/17/2005	GCR